

FORM PTO-1449/A and B (Modified)		APPLICATION NO.: 10/005,592	ATTY. DOCKET NO.: V00077.70149.US
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		FILING DATE: October 26, 2001	CONFIRMATION NO.: 8123
		APPLICANT: George Gammel et al.	
		GROUP ART UNIT: 2881	EXAMINER: Not Yet Assigned
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## U.S. PATENT DOCUMENTS

Examiner's Initials	Cite No.	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication or of issue of Cited Document MM-DD-YYYY
		Number	Kind Code		
<i>gfb</i>	1.	4,234,797	A	Ryding	11-18-1980
<i>gfb</i>	2.	4,361,762	A	Douglas	11-30-1982
<i>gfb</i>	3.	4,463,255	A	Robertson et al.	07-31-1984
<i>gfb</i>	4.	4,587,433	A	Farley	05-06-1986
<i>gfb</i>	5.	4,595,837	A	Wu et al.	06-17-1986
<i>gfb</i>	6.	4,786,814	A	Kolondra et al.	11-22-1988
<i>gfb</i>	7.	5,136,171	A	Leung et al.	08-04-1992
<i>gfb</i>	8.	5,354,381	A	Sheng	10-11-1994
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Examiner's Initials	Cite No.	Foreign Patent Document			Name of Patentee or Applicant of Cited Document (not necessary)	Date of Publication of Cited Document MM-DD-YYYY	Translation (Y/N)
		Office/ Country	Number	Kind Code			

## OTHER ART — NON PATENT LITERATURE DOCUMENTS

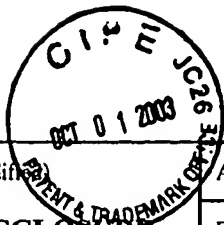
Examiner's Initials	Cite No	Include name of the author (in CAPITAL LETTERS) title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, relevant page(s), volume-issue number(s), publisher, city and/or country where published.	Translation (Y/N)	

EXAMINER <i>Jack Berman</i>	DATE CONSIDERED <i>3/1/04</i>
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<i>JP</i>		WO	99/03125		APPLIED MATERIALS, INC.	01-21-1999	

#### OTHER ART — NON PATENT LITERATURE DOCUMENTS

Examiner's Initials	Cite No	Include name of the author (in CAPITAL LETTERS) title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, relevant page(s), volume-issue number(s), publisher, city and/or country where published.	Translation (Y/N)	
<i>JP</i>		CURELLO, G. et al., "Charge Exchange in Eaton's NV-8250 Medium Current Ion Implanter," 1998 International Conference On Ion Implantation Technology Proceedings (Cat. No. 98EX144), Kyoto, Japan, 22- 26 June 1998, pages 543-545, vol. 1, XP002247112, Piscataway, NJ, USA, IEEE, USA; ISBN 0-7803-4538-X		

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